

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10798289	HEO, HAE-JIN
	<b>Examiner</b>	<b>Art Unit</b>
	TRAN, MY-CHAU T	2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	32, 84, 87, 88, 204, 690, 697	12/20/06	MCT
345	4, 5, 6, 32, 84, 87, 88, 204, 690, 697	12/22/06	MCT
UPDATED	UPDATED	05/09/07	MCT
UPDATED	UPDATED	07/19/07	MCT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
PALM Inventor; WEST - see printout	12/20/06	MCT
UPDATED - see printout	05/09/07	MCT
UPDATED - see printout	07/19/07	MCT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	87, 88, 690, 697, see printout	07/19/07	MCT